Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/677,362	QIU ET AL.
Examiner	**Art Unit**
CHUONG T. HO	2616

SEARCHED			
Class	Subclass	Date	Examiner
370 370 H55	329 ✓ 330 509 ✓	04/28/07	CH
H55	510		
H55	512 ✓		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST (Text search, Class search) EAST STN	04/28/07	CH
IEEE		